

L Number	Hits	Search Text	DB	Time stamp
1	0	microcircuit and package and stacking and pretested adj circuit	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 10:51
2	0	package and stacking and pretested adj circuit	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 10:52
3	0	package and pretested adj circuit	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 10:52
4	2	pretested adj circuit	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 10:54
5	5	pretested and microcircuit	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 10:57
6	19	pre-tested and circuit and 29/\$.ccis.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 10:58

L Number	Hits	Search Text	DB	Time stamp
1	43	circuit adj board and encapsulated and grinding and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:22
2	34	IC and encapsulated and grinding and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:35
3	0	20020100600.URPN.	USPAT	2002/08/06 08:26
4	1	microcircuit and encapsulated and grinding and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:35
5	66	circuit and encapsulated and grinding and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:39
6	5	("3370203" "3577037" "4151543" "4363076" "4398235").PN.	USPAT	2002/08/06 08:37
9	9	circuit and encapsulated and grinding and polishing and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:40
10	8	BGA and encapsulated and grinding and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:42
11	3	("5304534" "5373627" "5847445").PN.	USPAT	2002/08/06 08:41
12	13	encapsulated and grinding and stacking and 29/\$.ccis.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:44
13	1	chip and encapsulated near grinding and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:45
14	1	encapsulated near grinding and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:47

15	0	20010055856.URPN.	USPAT	2002/08/06 08:46
16	7	grinding and stacking and 438/460.ccIs.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:55
17	4	grinding and stacking and 438/462.ccIs.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:55
18	2	grinding and stacking and 438/465.ccIs.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 08:57
19	1	"5646067".PN.	USPAT	2002/08/06 08:56
20	0	20010055856.URPN.	USPAT	2002/08/06 08:57
21	178	grinding and stacking and 29/\$.ccIs.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 09:25
22	6	("4750090" "5657537" "5699234" "5739578" "5844168" "6290540").PN.	USPAT	2002/08/06 08:59
23	14	("4237522" "4254446" "4783695" "4835704" "4894115" "4933042" "5019946" "5111278" "5161093" "5279029" "5285571" "5347928" "5466634" "5502667").PN.	USPAT	2002/08/06 09:01
24	40	("2907926" "3029495" "3065384" "3070729" "3139559" "3152288" "3370203" "3746934" "3748479" "4520427" "4525921" "4551629" "4612083" "4638348" "4646128" "4706166" "4727410" "4764846" "4801992" "4818728" "4833568" "4862249" "4868712" "4879258" "4894706" "4901136" "4902641" "4926241" "4956746" "4983533" "5016138" "5019943" "5019946" "5051865" "5064771" "5071792" "5091331" "5162254" "5266833" "5347428").PN.	USPAT	2002/08/06 09:06
25	9	grinding and stacking and (albert et al).in.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/06 09:27

-	2	5086018.pn.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT;	2002/08/05 14:59
-	2	6342398.pn.	US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT;	2002/08/05 13:45
-	2	6060373.pn.	US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT;	2002/08/05 13:45
-	3	5454160.pn.	US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT;	2002/08/05 13:45
-	7	microcircuit and package and stacking and 29\$/ccls.	IBM_TDB USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB USPAT	2002/08/05 13:59
-	71	5086018.URPN.	USPAT	2002/08/05 14:53
-	36	("4862245" "4937656" "4949161" "5086018" "5147815" "5218168" "5234866" "5250840" "5256598" "5303120" "5327009" "5331200" "5334873" "5357139" "5360992" "5365113" "5381036" "5384488" "5434106" "5438478" "5508565" "5521426" "5523617" "5528075" "5530292" "5563443" "5585667" "5585668" "5612259" "5637915" "5696665" "5751057" "5780925" "5804870" "5811875" "6066515").PN.	USPAT	2002/08/05 14:56

	84	("3246386" "3290559" "3313986" "3377516" "3403300" "3515949" "3535595" "3614541" "3671812" "3746934" "3949274" "3959579" "4017963" "4116518" "4116519" "4288808" "4288841" "4364620" "4371912" "4379259" "4394712" "4398235" "4571663" "4574331" "4631573" "4638348" "4638406" "4642735" "4688864" "4696525" "4698663" "4706166" "4761681" "4770640" "4821007" "4841355" "4868712" "4884237" "4924352" "4953005" "4956694" "4996583" "4996587" "5016138" "5025307" "5031072" "5041395" "5043794" "5058265" "5086018" "5107328" "5128831" "5140745" "5155068" "5198888" "5222014" "5231304" "5239447" "5241454" "5281852" "5311401" "5313096" "5343075" "5343366" "5369058" "5373189" "5384689" "5397916" "5420751" "5426566" "5446313" "5479318" "5481133" "5493476" "5499160" "5514907" "5552963" "5561591" "5566051" "5586009" "5605592" "5612570" "5615475" "5723903").PN.	USPAT	2002/08/05 14:57
	14	("3746934" "4398235" "4521828" "4763188" "4796078" "4884237" "4953060" "4956694" "5151559" "5221642" "5270492" "5279029" "5367766" "5394010").PN.	USPAT	2002/08/05 14:58
	4	29/841.ccis. and IC and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:02
	0	29/841.ccis. and "PEM" and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:02
	0	29/841.ccis. and "PEM"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:02
	0	29/841.ccis. and "Plastic encapsulant microcircuit"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:03

-	0	"Plastic encapsulant microcircuit"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:03
-	0	"plastic encapsulant microcircuit"	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:04
-	0	plastic same encapsulant near microcircuit	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:04
-	14	plastic same encapsulant near circuit	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:05
-	0	encapsulant near circuit and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:06
-	263	encapsulant and circuit and stacking	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:06
-	31	encapsulant and circuit and stacking and 174/\$.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:07
-	13	encapsulant and circuit and stacking and 439/\$.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:08
-	10	encapsulant and circuit and stacking and 228/\$.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:08
-	134	encapsulant and circuit and stacking and 257/\$.ccls.	USPAT; US-PGPUB; EPO; JPO; DERWENT; IBM_TDB	2002/08/05 15:09